Tantalum Solid Electrolytic Chip Capacitors - Undertab Series





FEATURES

- · Undertab Terminations Layout:
 - High Volumetric Efficiency
 - High PCB Assembly Density
 - High Capacitance in Smaller Dimensions
- 3x Reflow 260°C Compatible
- 100% Surge Current Tested
- Consumer Applications (e.g. PCMCIA/USB Wireless Express Cards, Mobiles, MP3 etc.)
- 3 Case Sizes Available
- CV Range: 47-220µF / 4-10V



LEAD-FREE

LEAD-FREE COMPATIBLE

APPLICATIONS

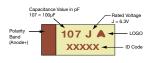
- Mobile Phones
- **Tablets**
- MP3/4 Players

CASE DIMENSIONS: millimeters (inches)

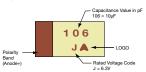
Code	EIA Code	EIA Metric	L±0.20 (0.008)	W+0.20 (0.008) -0.10 (0.004)	H max.	W _P ±0.10 (0.004)	W _N ±0.10 (0.004)	A _P ±0.10 (0.004)	A _N ±0.10 (0.004)	S Min.
М	0805	2012-09	2.05 (0.081)	1.30 (0.051)	0.90 (0.035)	1.00 (0.039)	1.00 (0.039)	0.85 (0.033)	0.85 (0.033)	0.40 (0.016)
N	0805	2012-10	2.05 (0.081)	1.30 (0.051)	1.00 (0.039)	1.00 (0.039)	1.00 (0.039)	0.85 (0.033)	0.85 (0.033)	0.40 (0.016)
Т	1210	3528-12	3.50 (0.138)	2.80 (0.110)	1.20 (0.047)	2.50 (0.098)	2.10 (0.083)	1.15 (0.045)	1.35 (0.053)	1.00 (0.039)

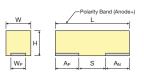
MARKING

T, CASE



M, N CASE







HOW TO ORDER

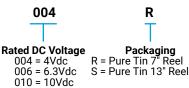




to follow)



M **Tolerance** $M = \pm 20\%$





TECHNICAL SPECIFICATIONS

Technical Data:			All technical data relate to an ambient temperature of +25°C						
Capacitance Range:			47 μF to 220 μF						
Capacitance Tolerance:		±20%							
Rated Voltage (V _R)	tated Voltage (V _R) -55°C ≤ +40°C:		6.3	10					
rategory Voltage (V _c) at 85°C:		2	3.2	5					
Category Voltage (V _c) at 125°C:		0.8	1.3	2					
Temperature Range:		-55°C to +125°C with category voltage							
Reliability:	0.2% per 1000 hours at 85°C, 0.5xV $_{R}$ with 0.1 Ω /V series impedance with 60% confidence level								



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CAPACITANCE AND RATED VOLTAGE RANGE (LETTER DENOTES CASE SIZE)

Capac	itance	Rated Voltage DC to 40°C / 0.5DC to 85°C/ 0.2DC to 125°C							
μF	Code	4V (G)	6.3V (J)	10V (A)					
47	476			M(6000)/N(6000)					
100	107	N(5200)							
150	157			T(1500)					
220	227	T(1500)	T(1500)	T(1300)					

Released ratings, (ESR ratings in mOhms in parentheses)

Note: Voltage ratings are minimum values. KYOCERA AVX reserves the right to supply higher voltage ratings in the same case size, to the same reliability

RATINGS & PART NUMBER REFERENCE

	0	Capacitance (µF)	Rated Voltage (V)		Category Voltage (V)	Category Temperature (°C)	Maximum Surge Current (A)	DCL Max. (µA)	ESR Max. @ 100kHz (mΩ)	100kHz RMS Current (mA)			
Part Number	Case Size									25°C	85°C	125°C	MSL
4 Volt @ 40°C													
TLNN107M004#5200	N	100	4	40	0.8	125	0.4	20	5200	88	79	35	3
TLNT227M004#1500	Т	220	4	40	0.8	125	1.0	17.6	1500	216	194	86	3
	6.3 Volt @ 40°C												
TLNT227M006#1500	Т	220	6.3	40	1.3	125	1.6	26.4	1500	216	194	86	3
					10	Volt @ 40°C							
TLNM476M010#6000	М	47	10	40	2	125	0.8	9.4	6000	82	73	33	3
TLNN476M010#6000	N	47	10	40	2	125	0.8	9.4	6000	82	73	33	3
TLNT157M010#1500	T	150	10	40	2	125	2.6	30	1500	216	194	86	3
TLNT227M010#1300	T	220	10	40	2	125	2.9	44	1300	232	209	93	3

Moisture Sensitivity Level (MSL) is defined according to J-STD-020.

All technical data relates to an ambient temperature of +25°C. Capacitance is measured at 120Hz, 0.5V RMS with a maximum DC bias of 2.2 volts.

DCL is measured at rated voltage after 5 minutes.

ESR allowed to move up to 1.25 times catalogue limit post mounting

DCL allowed to move up to 2.00 times catalogue limit post mounting

For typical weight and composition see page 259.

NOTÉ: KYOCERA AVX reserves the right to supply higher voltage ratings or tighter tolerance part in the same case size, to the same reliability standards.

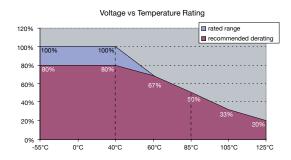


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QUALIFICATION TABLE

TEST	TLN series (Temperature range -55°C to +125°C)										
1591		Condition	Characteristics								
	Apply rated volta	ige (Ur) at 40°C and	Visual examination	no visible damage							
Endurance	1 '''	5°C for 2000 hours	DCL	2 x initial limit							
Endurance	circuit impedance	e of ≤0.1Ω/V. Stabi	ΔC/C	within +	within +5/-30% of initial value						
	temperature for 1	1-2 hours before m	ESR	1.25 x ir	1.25 x initial limit						
	Store at 65°C and	d 90-95% relative h	Visual examination	no visib	no visible damage						
Humidity	hours, with no ap	oplied voltage. Stab	DCL	2 x initia	2 x initial limit						
пиннину	temperature and	humidity for 1-2 ho	ΔC/C	within ±	within ±10% of initial value						
	measuring.			ESR	1.25 x ir	1.25 x initial limit					
	Step	Temperature°C +20	Duration(min) 15	1	+20°C	-55°C	+20°C	+85°C	+125°C	+209	
Temperature	2	-55 +20	15	DCL	2 x IL*	n/a	2 x IL*	20 x IL*	25 x IL*	2 x I	
Stability	4	+85	15	ΔC/C	n/a	+5/-20%	±10%	+20/-0%	+25/-0%	±10	
	5 6	+125 +20	15 15	ESR	1.25 x IL*	2.5 x IL*	1.25 x IL*	1.25 x IL*	1.25 x IL*	125x	
	Apply 1.3x rated	voltage (Ur) at 40°	Visual examination	no visible damage							
Surge	of duration 6 min	n (30 sec charge, 5	DCL	2 x initial limit							
Voltage	, , ,	gh a charge / disch	ΔC/C	within ±5% of initial value							
	of 1000Ω		ESR	1.25 x initial limit							
			Visual examination	no visible damage							
Mechanical	MIL-STD-202 Method 213 Condition C			DCL	initial limit						
Shock				ΔC/C	within ±5% of initial value						
SHOCK				DF	initial lir	initial limit					
			ESR	initial limit							
			Visual examination	no visible damage							
				DCL	initial limit						
Vibration	MIL-STD-202, Me	ethod 204, Condition	on D	ΔC/C	within ±	within ±5% of initial value					
				DF	initial lir	initial limit					
				ESR	initial limit						

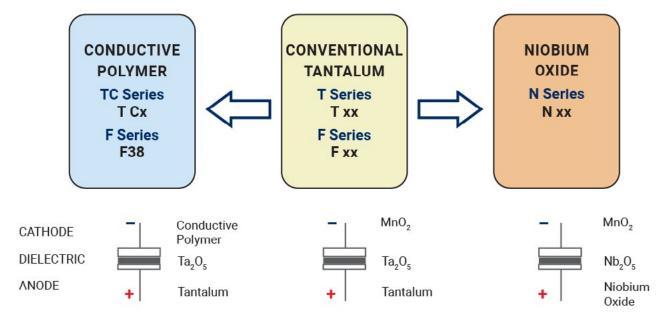
^{*}Initial Limit





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SOLID ELECTROLYTIC CAPACITOR ROADMAP



FIVE CAPACITOR CONSTRUCTION STYLES



SERIES LINE UP: CONVENTIONAL SMD MnO,

